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TABLE OF CONTENTS

Near-field Nanoscale Investigation of Optical Properties of Bi₂Se₃ Thin-films	1
<i>S. Grefe, M. Tan, S. Derakhshan, Y. Abate</i>	
Magnetic Domain Structure of Nanocrystalline Zr_{18-x}Hf_xCo₈₂ Ribbons:	
Effect of Hf	7
<i>L. Yue, I. Al-Omari, W. Zhang, R. Skromski, D. Sellmyer</i>	
Heat Transfer between a Self-Heated Scanning Thermal Microscopy Probe and a Cold Sample: Impact of the Probe Temperature	13
<i>A. Assy, S. Gomes, S. Lefevre, P. Chapuis</i>	
Crystallinity and Mechanical Properties of Polypropylene-based Graphene Nanocomposites Studied with Atomic Force Microscopy and Raman Spectroscopy	19
<i>K. Gronski, R. Flaig, J. Camacho, Y. Wu, J. Hamilton</i>	
Conductivity Measurement Of Individual SnS Nanoparticles By Peak Force AFM	25
<i>C. Prastani, A. Vetushka, M. Hyvl, A. Fejfar, M. Nanu, D. Nanu, R. Schropp, J. Rath</i>	
Effects of Operating Conditions on Bimodal Atomic Force Microscopy	31
<i>I. Chakraborty, D. Yablon</i>	
Author Index	